

S/N

Unknown

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

SHIMIZU

Examiner:

Unknown

Serial No.:

Unknown

Group Art Unit:

Unknown

Filed:

4 May 2005

Docket:

10921.320USWO

Title:

AREA IMAGE SENSOR

CERTIFICATE UNDER 37 CFR 1.10

Express Mail mailing label number: ED874641927US

Date of Deposit: 4 May 2005

I hereby certify that the papers listed below are being deposited with the United States Postal Service Express Mail Post Office to Addressee service under 37 CFR 1.10 in an envelope addressed to: Mail Stop Application, Commissioner for Patents, P.O. Box 1450, Arlington, VA 22313-1450.

Name: Raquel M. Zamorano-Carey

INFORMATION DISCLOSURE STATEMENT (37 C.F.R. § 1.97(c))

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

With regard to the above-identified application, the items of information listed on the enclosed Form 1449 are brought to the attention of the Examiner.

This statement should be considered because it is submitted within three months of the filing date of the above-identified application, which is not an application under 37 C.F.R. §1.53(d). Accordingly, no fee is due for consideration of the items listed on the enclosed Form 1449.

In accordance with 37 C.F.R. §1.98(a)(2), a copy of US references are not provided as the application is being filed after 30 June 2003. A copy of all foreign documents or other information listed on the enclosed Form 1449 is provided.

Applicants respectfully bring to the Examiner's attention that eighteen of the references listed on the enclosed Form 1449 were sited in an International Search Report, enclosed herewith.

A concise explanation of the relevance of each non-English language document or other information is as follows (37 C.F.R. §1.98(a)(3)): EP 1 067 777 corresponds to JP 2001-16509. US 2002-0008760 A1 corresponds to JP 2001-275029. US 2003/0156204 A1 corresponds to JP 2002-237998. US 5,872,596 corresponds to JP 6-205307. English abstracts are provided for all other foreign references.

No representation is made that a reference is "prior art" within the meaning of 35 U.S.C. §§ 102 and 103 and Applicants reserve the right, pursuant to 37 C.F.R. § 1.131 or otherwise, to establish that the reference(s) are not "prior art." Moreover, Applicants do not represent that a reference has been thoroughly reviewed or that any relevance of any portion of a reference is intended.

Consideration of the items listed is respectfully requested. Pursuant to the provisions of M.P.E.P. 609, it is requested that the Examiner return a copy of the attached Form 1449, marked as being considered and initialed by the Examiner, to the undersigned with the next official communication.

Respectfully submitted,

HAMRE, SCHUMANN, MUELLER &

LARSON, P.C. P.O. Box 2902-0902

Minneapalis, MN 55402-0903

Dated: 4 May 2005

Mouglas P. Mueller

DPM:hjm

Date Mailed: 4 May 2005

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Sheet I of I

FORM 1449*

INFORMATION DISCLOSURE STATEMENT

Docket Number: 10921.320USWO Application Number 533925

IN AN APPLICATION
(Use several sheets if necessary)

Applicant: SHIMIZU

Filing Date: 4 May 2005

Group Art Unit: Unknown

		U.S.	PATENT DOCUMEN	TS .			
EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	2002/0008760 A1	24 Jan. 2002	NAKAMURA			-	
	2003/0156204 A1	21 Aug. 2003	SATO et al.				
	5 872 596	16 Feb. 1999	YANAI et al.				
		FOREIC	GN PATENT DOCUM	ENTS			
	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NC
	JP 9-247536	19 Sept. 1997	Japan			Abstract	
	JP 6-98080	8 April 1994	Japan			Abstract	
	JP 8-205034	9 Aug. 1996	Japan			Abstract	
	JP 6-152586	31 May 1994	Japan			Abstract	
	JP 4-281681	7 Oct. 1992	Japan			Abstract	
	JP 2000-69371	3 May 2000	Japan			Abstract	
	JP 2001-16509	19 Jan. 2001	Japan			EP 1 067 777	
	EP 1 067 777	10 Jan. 2001	ЕРО				
	JP 2001-275029	5 Oct. 2001	Japan			US 2002/0008760 A1	
	JP 54-80024	26 June 1979	Japan			Abstract	
	JP 2002-237998	23 Aug. 2002	Japan			US 2003/0156204 A1	
	JP 6-205307	22 July 1994	Japan			US 5 872 596	
	JP 2-60380	28 Feb. 1990	Japan		<u>A</u> - 1	Abstract	
	JP 5-48460	26 Feb. 1993	Japan	10		Abstract	
	JP 2001-346102	14 Dec. 2001	Japan			Abstract	
	JP 2001-36816	9 Feb. 2001	Japan			Abstract	

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PATENT TRADEMARK OFFICE

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.